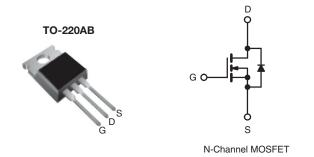


Power MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	60	60				
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V	0.20				
Q _g (Max.) (nC)	11	11				
Q _{gs} (nC)	3.	3.1				
Q _{gd} (nC)	5.8	5.8				
Configuration	Sing	Single				



FEATURES

- Dynamic dV/dt Rating
- 175 °C Operating Temperature
- Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC





DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION			
Package	TO-220AB		
Lead (Pb)-free	IRFZ14PbF		
Leau (Fb)-liee	SiHFZ14-E3		
SnPb	IRFZ14		
SIFD	SiHFZ14		

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage ^f			V_{DS}	60	V	
Gate-Source Voltagef	V_{GS}	± 20	V			
Continuous Drain Current	V_{GS} at 10 V $T_{C} = 25 ^{\circ}C$ $T_{C} = 100 ^{\circ}C$			10		
Continuous Drain Current	V _{GS} at 10 V	T _C = 100 °C	I _D	7.2	Α	
Pulsed Drain Current ^a			I _{DM}	40	1	
Linear Derating Factor				0.29	W/°C	
Single Pulse Avalanche Energy ^b	E _{AS}	47	mJ			
Maximum Power Dissipation $T_C = 25 ^{\circ}C$			P_{D}	43	W	
Peak Diode Recovery dV/dtc	dV/dt	4.5	V/ns			
Operating Junction and Storage Temperature Rang	T _J , T _{stg}	- 55 to + 175	- °C			
Soldering Recommendations (Peak Temperature) for 10 s						300 ^d
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N · m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 25 V; starting T_J = 25 °C, L = 1.47 mH, R_g = 25 Ω , I_{AS} = 8 A (see fig. 12).
- c. $I_{SD} \leq 10$ A, $dI/dt \leq 90$ A/µs, $V_{DD} \leq V_{DS}, \, T_J \leq 175$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-	62			
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W		
Maximum Junction-to-Case (Drain)	R _{thJC}	-	3.5			

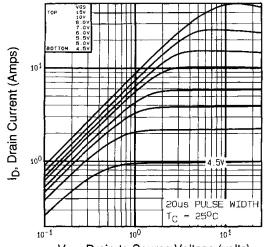
PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	= 0 V, I _D = 250 μA	60	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA	-	0.063	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	· V _{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 20 V	-	-	± 100	nA
Zone Onto Voltago Dunio Ocument	I _{DSS}	$V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}$		-	-	25	μΑ
Zero Gate Voltage Drain Current		$V_{DS} = 48 \text{ V}$	V _{DS} = 48 V, V _{GS} = 0 V, T _J = 150 °C		-	250	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	$I_D = 6.0 \text{ A}^b$	-	-	0.20	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	25 V, I _D = 6.0 A ^b	2.4	-	-	S
Dynamic							
Input Capacitance	C _{iss}		V _{GS} = 0 V,	-	300	-	pF
Output Capacitance	C _{oss}		$V_{DS} = 25 \text{ V},$	-	160	-	
Reverse Transfer Capacitance	C _{rss}] f = 1.	0 MHz, see fig. 5	-	29	-	
Total Gate Charge	Qg			-	-	11	1
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$V_{GS} = 10 \text{ V}$ $I_D = 10 \text{ A}, V_{DS} = 48 \text{ V},$ see fig. 6 and 13b		-	3.1	nC
Gate-Drain Charge	Q_{gd}		great and re	-	-	5.8	
Turn-On Delay Time	t _{d(on)}	$V_{DD} = 30 \text{ V}, I_D = 10 \text{ A}, \\ R_g = 24 \ \Omega, R_D = 2.7 \ \Omega, \\ \text{see fig. } 10^b$		-	10	-	- ns
Rise Time	t _r			-	50	-	
Turn-Off Delay Time	t _{d(off)}			-	13	-	
Fall Time	t _f			-	19	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	-11
Internal Source Inductance	L _S			-	7.5	-	nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	10	Α
Pulsed Diode Forward Current ^a	I _{SM}			-	-	40	
Body Diode Voltage	V_{SD}	T _J = 25 °C, I _S = 10 A, V _{GS} = 0 V ^b		-	-	1.6	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 10 A, dI/dt = 100 A/μs ^b		_	70	140	ns
Body Diode Reverse Recovery Charge	Q_{rr}			-	0.20	0.40	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)				L _D)	

Notes

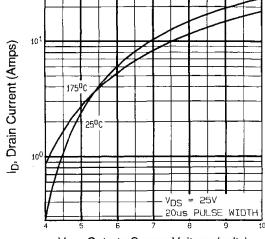
- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width $\leq 300~\mu s;$ duty cycle $\leq 2~\%.$



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



V_{DS}, Drain-to-Source Voltage (volts) Fig. 1 - Typical Output Characteristics, T_C = 25 °C



V_{GS}, Gate-to-Source Voltage (volts)

Fig. 3 - Typical Transfer Characteristics

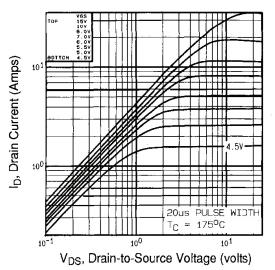


Fig. 2 - Typical Output Characteristics, $T_C = 175$ °C

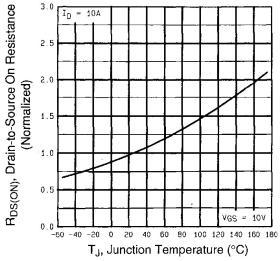
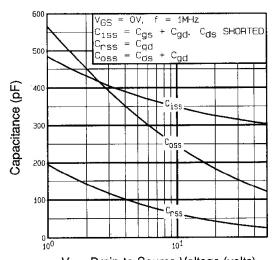


Fig. 4 - Normalized On-Resistance vs. Temperature





V_{DS}, Drain-to-Source Voltage (volts)
Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

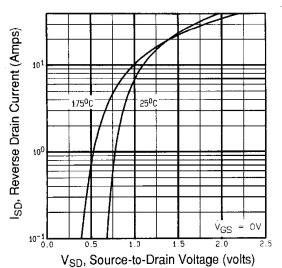


Fig. 7 - Typical Source-Drain Diode Forward Voltage

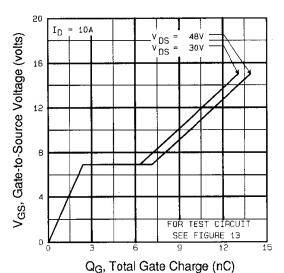


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

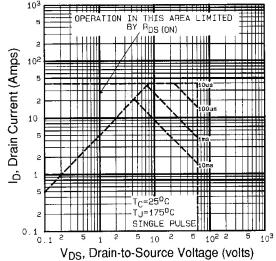


Fig. 8 - Maximum Safe Operating Area





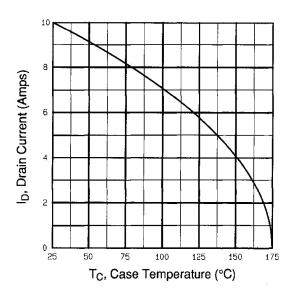


Fig. 9 - Maximum Drain Current vs. Case Temperature

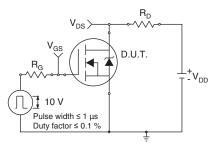


Fig. 10a - Switching Time Test Circuit

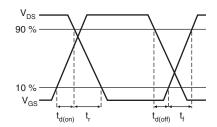


Fig. 10b - Switching Time Waveforms

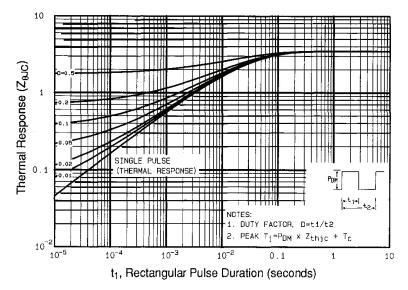


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

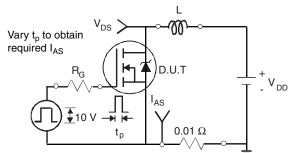


Fig. 12a - Unclamped Inductive Test Circuit

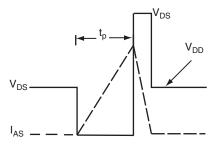


Fig. 12b - Unclamped Inductive Waveforms



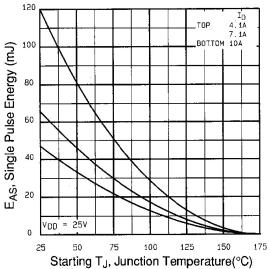


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

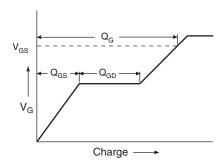


Fig. 13a - Basic Gate Charge Waveform

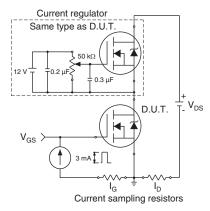
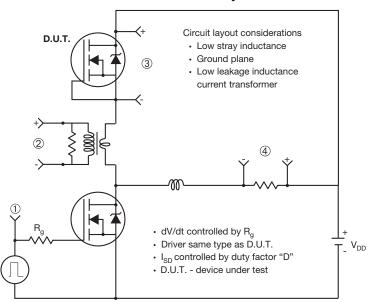


Fig. 13b - Gate Charge Test Circuit





Peak Diode Recovery dV/dt Test Circuit



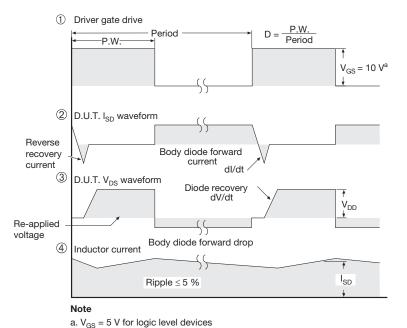


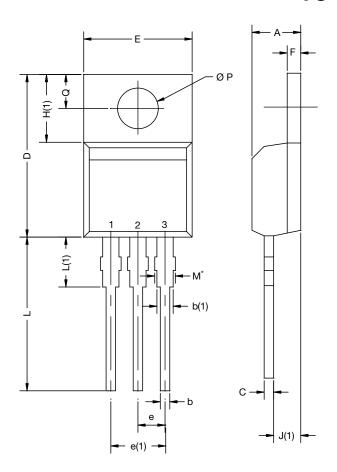
Fig. 14 - For N-Channel

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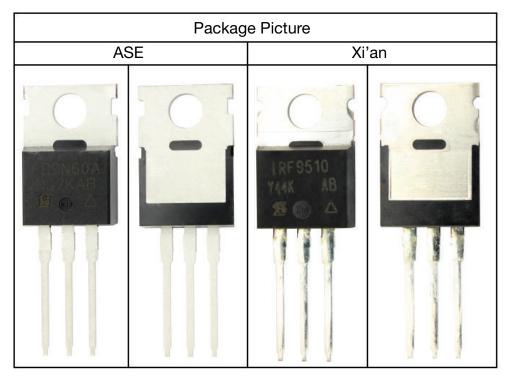
TO-220-1



DIM	MILLIN	IETERS	INCHES			
DIM.	MIN.	MAX.	MIN.	MAX.		
Α	4.24	4.65	0.167	0.183		
b	0.69	1.02	0.027	0.040		
b(1)	1.14	1.78	0.045	0.070		
С	0.36	0.61	0.014	0.024		
D	14.33	15.85	0.564	0.624		
E	9.96	10.52	0.392	0.414		
е	2.41	2.67	0.095	0.105		
e(1)	4.88	5.28	0.192	0.208		
F	1.14	1.40	0.045	0.055		
H(1)	6.10	6.71	0.240	0.264		
J(1)	2.41	2.92	0.095	0.115		
L	13.36	14.40	0.526	0.567		
L(1)	3.33	4.04	0.131	0.159		
ØР	3.53	3.94	0.139	0.155		
Q	2.54	3.00	0.100	0.118		
ECN: X15-0364-Rev. C, 14-Dec-15 DWG: 6031						

Note

 \bullet $M^{\star}=0.052$ inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



Revison: 14-Dec-15 1 Document Number: 66542

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Vishay

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